

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/663,480	HONDA ET AL.		
Examiner	Art Unit		
Christian P. Chace	2189		

	SEARCHED							
Class	ass Subclass Date		Examiner					
370	379,382 383,392, 399,	7 7 28/0	5	C	PC			
	395.31, 395.72							
709	238,245							
710	26,316							
711	205,206,							
	209	d		0				
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INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)						
	DATE	EXMR				
Inventor Nane eDAN, PALM	7/22/05	OC				
EAST (all DB-s)	7/28/05	CPC				
updated "Special" search: 711/6,111,114,154, 165,179,173, 202, 203, 718/1	7/28/05	OC				
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